Se	arch Notes	

 Application/Control No.	Applicant(s)/Patent under Reexamination
10/072,898	EBERLE ET AL.
Examiner	Art Unit
Joseph T. Phan	2614

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Class	Subclass	Date	Examiner
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INT	ERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated East Search	4/27/2007	JTP